KPCI-3110

1.25MHz, 12-Bit, High Speed Multifunction Board



- 12-bit resolution
- Maximum sampling rate of 1.25MS/s
- 32 single-ended or 16 differential analog inputs
- 2 analog outputs, waveform quality, up to 500kS/s
- 16 high speed digital I/O lines, up to 3MHz
- 4 counter/timers
- Low gain (1, 2, 4, 8)
- Pre-, post-, and about-triggering
- 1024-location channel-gain queue
- 32-bit DriverLINX® drivers plus a suite of bundled software including ExceLINX®, VisualSCOPE®, TestPoint®, and LabVIEW® drivers

The KPCI-3110 is the perfect solution for demanding measurements, offering a combination of speed, resolution, high channel count, and quality that few other boards can match. Whether you're developing a new product or simply trying to understand and interpret physical phenomena, the KPCI-3110 provides the capability you need at a great price.

Functional Description

The multifunction KPCI-3110 board combines high speed analog inputs and analog outputs. This data acquisition board provides input speeds of up to 1.25MHz and output speeds of up to 500kS/s. The KPCI-3110 also features 16 digital I/O lines and four counter/timers. In addition, this PCI-bus board includes 32-bit DriverLINX software drivers, TestPoint drivers, and LabVIEW VIs.

High Speed Analog Inputs

The KPCI-3110's high speed analog inputs enable the user to sample data at speeds up to 1.25MS/s. Some typical high speed applications include high speed data acquisition and statistical sampling, testing of electrical components and subassemblies, continuous process monitoring, and industrial control and automation.

The KPCI-3110 data acquisition board is ideally suited to any application requiring accurate, high speed measurement of analog inputs. The analog inputs are software configurable for single-ended or differential inputs and bipolar or unipolar input ranges. An Amp Low connection allows single-ended inputs to be referenced to a common point other than ground to provide 32 pseudo-differential inputs.

For added flexibility, a 1024-location channel-gain queue allows you to sample non-sequential channels and channels with different gains.

The Calibration utility allows both manual and automatic software calibrations.

Analog Input Acquisition Modes

The KPCI-3110 can acquire a single value from any channel or a number of samples from multiple channels. To acquire data from multiple channels, the KPCI-3110 board provides two scan modes: continuously paced and triggered. Both scan modes can be paced using an internal or an external clock.

The Continuously Paced mode allows a board to continuously scan the channel-gain queue and acquire data until stopped or until a specific number of samples are acquired. The Triggered Scan mode allows a board to scan the channel-gain queue at high speeds with a programmed interval between scans, emulating a simultaneous sample-and-hold operation. Use an external trigger or an internal clock to retrigger a Triggered Scan operation to cycle through the channel-gain queue up to 256 times per trigger. This allows the acquisition of a waveform of data per channel for each trigger (up to 256kSamples per trigger).

The KPCI-3110 provides several triggering modes, including pre-trigger, post-trigger, and about-trigger modes. The trigger source can be an analog or digital signal. The level of the analog trigger can be from -10V to +10V.

- Pre-trigger mode allows acquisition to occur until an external trigger occurs.
- Post-trigger is the standard acquisition mode; acquisition begins after an internal or external trigger event and continues until an end condition occurs or the specified number of samples are collected.
- About-trigger mode allows acquisition to occur both before and after an external trigger.

Use an internal or an external clock to pace the analog inputs. The internal clock can be set to acquire data from one or more channels from 1S/s up to 1.25MS/s. To acquire data at slower rates, use an external source, or cascade two or more of the counter/timers and connect the out-

ACCESSORIES AVAILABLE

| 110000011100111111111111111111111111111 | |
|---|--|
| CAB-307 | 50-pin, 1-meter Shielded Cable for Analog Signals |
| CAB-307-3 | 50-pin, 3-meter Shielded Cable for Analog Signals |
| CAB-308 | 68-pin, 1-meter Shielded Cable for Digital Signals |
| CAB-308-3 | 68-pin, 3-meter Shielded Cable for Digital Signals |
| STP-3110 | Screw Terminal Panel |
| TESTPOINT | TestPoint Software Package |
| | |

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KPCI-3110

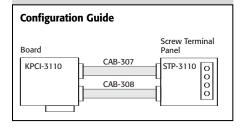
Ordering Information

KPCI-3110

1.25MHz, 12-Bit, High **Speed Multifunction Board**

APPLICATIONS

- · High speed measurement and data acquisition
- · Monitoring and control of production testing equipment
- **Continuous monitoring of process** variables
- On-line monitoring of quality specifications



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put to the external clock input. The external A/D sample clock and the digital trigger input signals are accessible through the connector.

Analog Outputs

The KPCI-3110 features two 12-bit analog output channels with an output range of +10V. The analog outputs can be used concurrently with the analog inputs to perform gap-free simultaneous stimulus and response. The analog outputs can be triggered synchronously with, or independently of, the analog inputs using the analog threshold trigger or the dedicated digital trigger input. An internal or external source clocks the analog outputs. The analog outputs can be updated simultaneously at a rate of up to 500kS/s each (system dependent), and are set to 0V at power-up.

The onboard FIFO can contain from two to 4096 waveforms samples with update rates at a guaranteed 500kS/s. Repetitive waveforms can be loaded into the onboard FIFO, and the data in this FIFO can be continuously cycled through.

Digital I/O

This board features 16 digital I/O lines that can be programmed into two banks of eight lines for input or output. The status of the digital inputs can be read at high speeds by including the digital input lines as a channel in the analog channel-gain queue. This dynamic digital input feature time stamps the digital inputs in relation to the analog inputs. In this mode, all digital input lines are read as one word. The digital outputs can drive external solid-state relay modules with its 12mA sink and 15mA source.

These boards also supply two auxiliary digital outputs. These digital outputs change state when a specified analog input is read, providing a triggering source or a synchronization source for external circuitry or other data acquisition boards.

Counter/Timers

These boards provide four 16-bit counter/timers for use in many purposes, including: counting events, creating a one-shot or frequency output, and measuring frequency input. They can also be used to set the duty cycle, frequency, and output polarity of the output pulse.

These counter/timers can be cascaded. Cascade two counter/timers internally through software. Cascade three or four counter/timers externally on a screw terminal accessory.

Digital Input and Output Connector Analog Trigger Return Shield Ground Analog Trigger Shield Ground Reserved 66 32 Reserved Reserved 65 64 Digital Ground Dynamic Digital Output 0 30 Digital Ground Digital Ground Dynamic Digital Output 1 Digital Ground 63 62 Digital I/O Bank A 4 61 27 Digital I/O Bank A O

Digital I/O Bank A 5 60 59 Digital I/O Bank A 1 25 Digital I/O Bank A 6 Digital I/O Bank A 2 Digital I/O Bank A 7 Digital Ground Digital I/O Bank A 3 Digital Ground Digital I/O Bank B 4 Digital I/O Bank B 0 22 56 55 54 53 52 Digital I/O Bank B 5 Digital I/O Bank B 1 Digital I/O Bank B 6 20 Digital I/O Bank B 2 Digital I/O Bank B 7 Digital Ground Digital I/O Bank B 3 Digital Ground Digital Ground External Gate 0 51 50 User Clock Input 0 User Counter Output 0 Digital Ground 49 User Clock Input 1 External Gate 1 Digital Ground User Clock Input 1 User Clock Input 2 48 47 External Gate 2 46 45 User Counter Output 2 Digital Ground User Clock Input 3 External Gate 3 44 10 User Counter Output 3 Digital Ground 43 42 External D/A Clock Input External D/A TTL Trigger Digital Ground Digital Ground 41 40 External A/D Sample Clock Input External A/D TTL Trigger Digital Ground

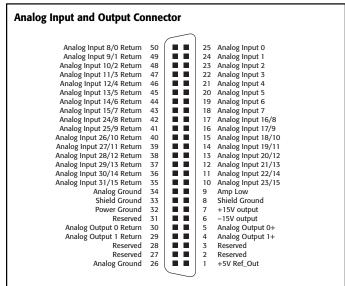
A/D Trigger Output A/D Sample Clock Output

Reserved

+5V Output

Connector Pin Assignments

The analog input and output connections are made with a 50-pin connector. The digital input and output connections are made with a 68-pin connector.



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Digital Ground

Digital Ground

Digital Ground

Reserved

39 38 37



KPCI-3110

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Analog Inputs

GENERAL

RESOLUTION: 12 bits

DATA THROUGHPUT (GAIN = 1): Single Channel: 1.25 MSamples/s, 0.03% accuracy. Multiple Channel (Scan): 1.0 MSamples/s, 0.05% accuracy; 750 kSamples/s, 0.03% accuracy.

CHANNEL-GAIN LIST: 1024 locations. INPUT FIFO SIZE: 1024 locations

INPUTS

NUMBER OF ANALOG INPUT CHANNELS: Single-Ended/Pseudo-Differential: 32. Differential: 16.

INPUT GAINS: 1, 2, 4, 8

INPUT RANGE: Bipolar: ±10, ±5, ±2.5, ±1.25V. Unipolar: 0-10, 0-5, 0-2.5, 0-1.25V.

DRIFT: Zero: $\pm 30\mu V + (+15\mu V * Gain)/^{\circ}C$. Gain: $\pm 30 \text{ ppm/}^{\circ}C$.

INPUT IMPEDANCE: $100M\Omega$, 10pF, Off. $100M\Omega$, 100pF, On.

INPUT BIAS CURRENT: ±20nA

COMMON MODE VOLTAGE: ±11V maximum (operational).

MAXIMUM INPUT VOLTAGE: ±20V maximum (protection).

CHANNEL ACQUISITION TIME: 1µs to 0.05%.

A/D CONVERSION TIME: 0.8µs.

ACCURACY

NONLINEARITY (integral): ±1.0 LSB

DIFFERENTIAL NONLINEARITY: ±0.75 LSB (no missing codes)

SYSTEM NOISE: 0.2 LSB rms, typical

CHANNEL-TO-CHANNEL OFFSET: ±40 0uV

SYSTEM ACCURACY (FULL SCALE):

Gain = 1: 0.01%

Gain = 2: 0.02%

Gain = 4: 0.02%Gain = 8: 0.03%

CLOCKING AND TRIGGER INPUTS

MAXIMUM A/D PACER CLOCK: 1.25MHz.

MINIMUM A/D PACER CLOCK: 1.19Hz.

EXTERNAL A/D SAMPLE CLOCK:

Minimum Pulse Width: 100ns (high); 150ns (low).

Maximum Frequency: 1.25MHz.

EXTERNAL A/D DIGITAL (TTL) TRIGGER:

High-Level Input Voltage: 2.0V minimum. Low-Level Input Voltage: 0.8V maximum.

Minimum Pulse Width: 100ns (high); 100ns (low)

EXTERNAL ANALOG TRIGGER

Input Type: Threshold sensitive.

Threshold Voltage: Programmable.

Threshold Range: -10V to +10V. Threshold Resolution: 8 bits/78mV per LSB.

Hysteresis: 50mV typical

Input Impedance: 12kΩ/20pF typical.

Maximum Input Voltage: ±20V (power on or off). Minimum Pulse Width: 100ns (high); 100ns (low).

JD SAMPLE CLOCK OUTPUT SIGNAL AND A/D TRIGGER OUTPUT SIGNAL:

Output Driver High Voltage:

2.0V minimum $(I_{OH} = -15\text{mA});$ 2.4V minimum ($I_{OH} = -3$ mA).

Output Driver Low Voltage:

0.5V maximum ($I_{OL} = 24$ mA);

0.4V maximum ($I_{OL} = 12$ mA).

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Analog Outputs

NUMBER OF ANALOG OUTPUT CHANNELS: 2 (voltage output).

RESOLUTION: 12 bits.

OUTPUT RANGE: ±10V (bipolar).

ERROR: Zero: Adjustable to 0. Gain: Adjustable to 0.

THROUGHPUT:

Full Scale: 200kHz maximum per channel.

100mV Step, continuously paced: 500kHz maximum per channel (system dependent).

100mV step, waveform mode: 500kHz maximum per channel (guaranteed).

FIFO BUFFER SIZE: 4096 locations.

CURRENT OUTPUT: ±5mA maximum load

OUTPUT IMPEDANCE: 0.1Ω maximum.

CAPACITIVE DRIVE CAPABILITY: 0.004µF (no oscillators).

NONLINEARITY (integral): ±1.0 LSB.

DIFFERENTIAL LINEARITY: ±0.75 LSB (monotonic).

PROTECTION: Short circuit to Analog Common.

POWER-ON VOLTAGE: ±10mV.

SETTLING TIME TO 0.01% OF FSR: 5μ s, 20V step; 2.0μ s, 100mV step.

SLEW RATE: 10V/µs

EXTERNAL D/A SAMPLE CLOCK: Minimum Pulse Width: 200ns (high); 150ns (low).

Maximum Frequency: 500kHz.

EXTERNAL D/A DIGITAL TRIGGER: High-Level Input Voltage: 2.0V minimum.

Low-Level Input Voltage: 0.8V maximum. Minimum Pulse Width: 100ns (high); 100ns (low).

Digital I/O

NUMBER OF LINES: 16 (bidirectional).

NUMBER OF PORTS: 2 (8 bits each)

INPUTS: High-Level Input Voltage: 2.0V minimum. Low-Level Input Voltage: 0.8V maximum.

High-level Input Current: 20μ A. Low-Level Input Current: -0.2mA.

MAXIMUM INTERNAL PACER CLOCK RATE: 1.25MHz.

MAXIMUM EXTERNAL PACER CLOCK RATE: 3MHz.

Output Driver High Voltage: 2.0V minimum ($I_{OH}=-15$ mA). 2.4V minimum ($I_{OH}=-3$ mA). Output Driver Low Voltage: 0.5V maximum ($I_{OL}=24$ mA). 0.4V maximum ($I_{OL}=12$ mA).

Counter/Timer

NUMBER OF COUNTER/TIMER CHANNELS: 4.

CLOCK INPUTS: High-Level Input Voltage: 2.0V minimum.

Low-Level Input Voltage: 0.8V maximum

Minimum Pulse Width: 100ns (high); 100ns (low).

Maximum Frequency: 5.0MHz. GATE INPUTS: High-Level Input Voltage: 2.0V minimum.

Low-Level Input Voltage: 0.8V maximum

Minimum Pulse Width: 100ns (high); 100ns (low).

COUNTER OUTPUTS

Output Driver High Voltage: 2.0V minimum ($I_{OH} = -15$ mA). 2.4V minimum ($I_{OH} = -3$ mA). Output Driver Low Voltage: 0.5V maximum ($I_{OL} = 24$ mA). 0.4V maximum ($I_{OL} = 12$ mA).

Physical and Environmental Specifications

PHYSICAL: Dimensions: 8.5 inches (length) by 4.2 inches (width). Analog I/O Connector: 50 pin Amp. Digital I/O Connector: 68 pin Amp

CERTIFICATION AND COMPLIANCE: FCC Class A verified; will not compromise FCC compliance of host computer CE

COMPLIANCE: Conforms to European Union directive 89/336/EEC (EMC directive), EN55022, and EN50082-1. (Product is CE marked.)

ENVIRONMENTAL: Operating Temperature Range: 0°C to 70°C. Storage Temperature Range: -25°C to 85°C. Relative Humidity: To 95%, noncondensing.

